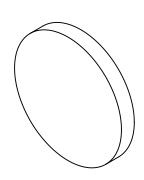
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 408 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 390nm @ 0° AOI T(abs): =50% FOR 400±4nm @ 0° AOI

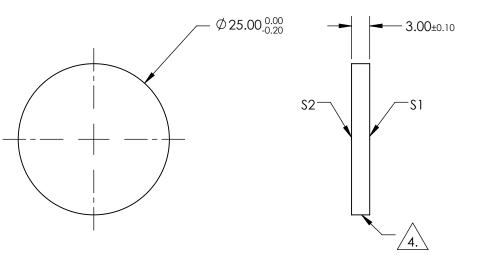
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

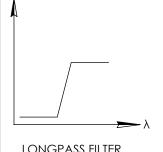
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



Τ

LONGINGSTIELER			_			Edmund Optics [®]
REV A	S1	\$2				
SHAPE	PLANO	PLANO		1		Ø25mm, 400nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20	THIRD ANGLE		TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%		1		
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	62981 SHEET 1 OF 1

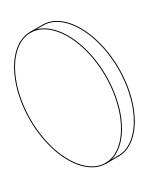
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 458 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 440nm @ 0° AOI T(abs): =50% FOR 450±4.5nm @ 0° AOI

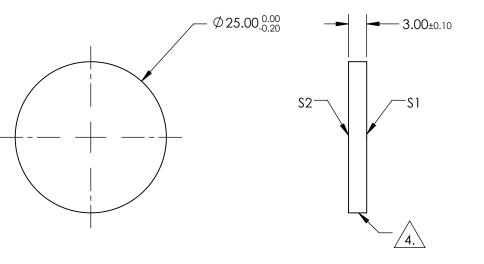
S2:SINGLE LAYER MgF2

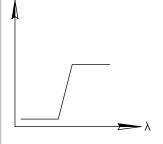
4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









Τ

LONGPASS FILTER						Edmund Optic	کدھ
REV A	S1	S2					5
SHAPE	PLANO	PLANO		1		Ø25mm, 450nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%					
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	62982	SHEET 1 OF 1

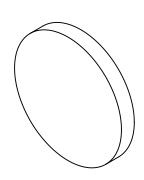
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 508 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 490nm @ 0° AOI T(abs): =50% FOR 500±5nm @ 0° AOI

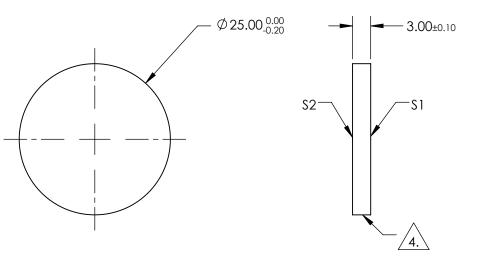
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

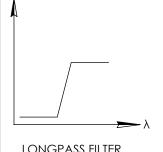
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



Τ

LONGINGSTIELER			_			Edmund Optic	C ®
REV A	S1	S2					, Э
SHAPE	PLANO	PLANO				Ø25mm, 500nm, HIGH PERFORMANC	∩F
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%					SHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	62983	1 OF 1

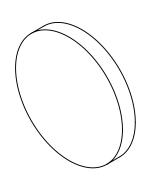
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 560 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 539nm @ 0° AOI T(abs): =50% FOR 550±5.5nm @ 0° AOI

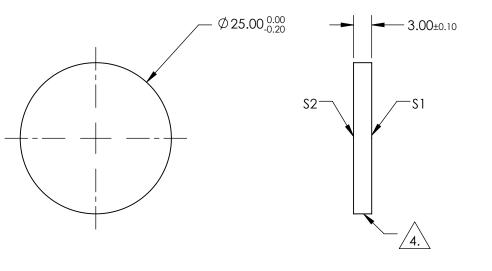
S2:SINGLE LAYER MgF2

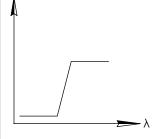
4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









Τ

LONGPASS FILTER			_			Edmund Optic	C ®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø25mm, 550nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%		 			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	62984	SHEET 1 OF 1

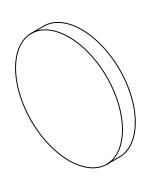
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 610 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 588nm @ 0° AOI T(abs): =50% FOR 600±6nm @ 0° AOI

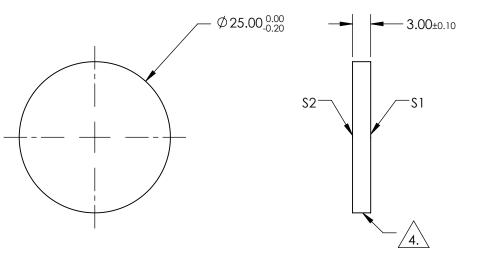
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

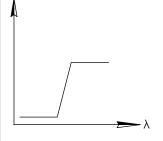
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



LONGPASS FILTER

Τ

LONGINGSTIELER			_			Edmund Optic	C ®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø25mm, 600nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20	THIRD ANGLE		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%		1			SHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	62985	1 OF 1

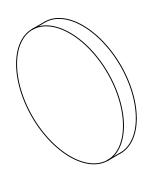
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 660 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 637nm @ 0° AOI T(abs): =50% FOR 650±6.5nm @ 0° AOI

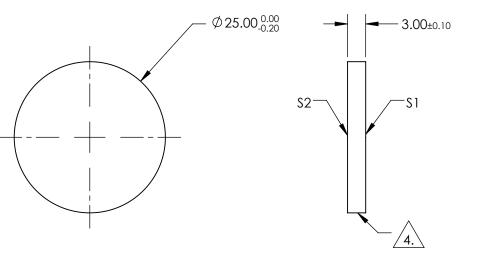
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

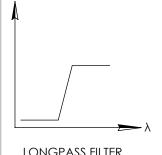
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



Τ

LONGINGSTILLER					[©] Edmund Optics [®]
REV A	S1	S2			
SHAPE	PLANO	PLANO			Ø25mm, 650nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%			SHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	62986 SHEET 1 OF 1

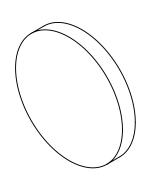
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 710 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 686nm @ 0° AOI T(abs): =50% FOR 700±7nm @ 0° AOI

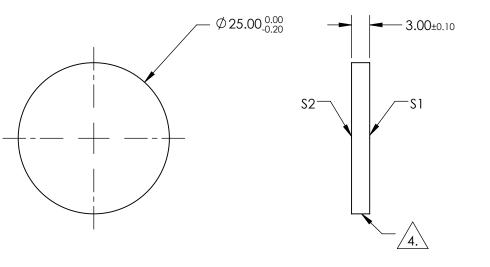
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

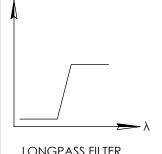
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



Τ

LONGINGSTILLER					Edmund Optics [®]
REV A	S1	S2			
SHAPE	PLANO	PLANO			Ø25mm, 700nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%			SHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	62987 SHEET

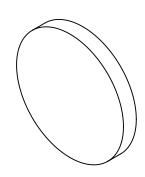
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 433 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 415nm @ 0° AOI T(abs): =50% FOR 425±4.25nm @ 0° AOI

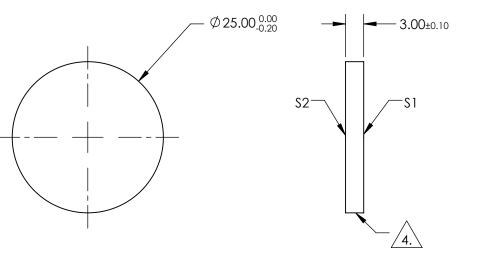
S2:SINGLE LAYER MgF2

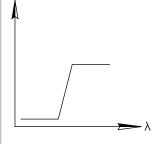
4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









Τ

LONGPASS FILTER						Edmund Optics	C ®
REV A	S1	S2					3
SHAPE	PLANO	PLANO				Ø25mm, 425nm, HIGH PERFORMANC	~F
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%					CUEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84742	Sheet 1 Of 1

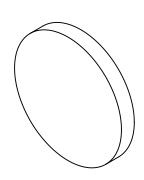
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 483 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 465nm @ 0° AOI T(abs): =50% FOR 475±4.75nm @ 0° AOI

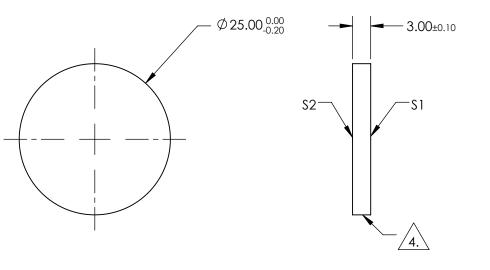
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

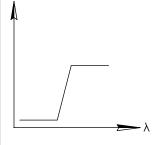
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



LONGPASS FILTER

Τ

LONGINGOTIETER			_			Edmund Optics [®]		
REV A	S1	S2						
SHAPE	PLANO	PLANO				Ø25mm, 475nm, HIGH PERFORMANCE		
SURFACE QUALITY	40-20	40-20	THIRD ANGLE		TITLE	LONGPASS FILTER		
CLEAR APERTURE	>80%	>80%						
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84743 SHEE 1 OF		

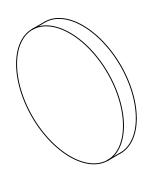
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 534 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 515nm @ 0° AOI T(abs): =50% FOR 525±5.25nm @ 0° AOI

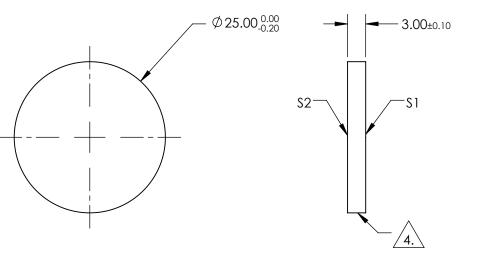
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

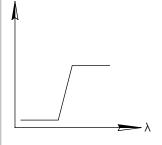
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



LONGPASS FILTER

Τ

LONGITIGGT					Edmund Optics [®]		
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø25mm, 525nm, HIGH PERFORMANC	F
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%		1			CUEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84744	Sheet 1 Of 1

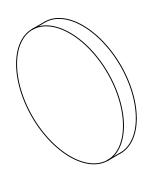
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 585 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 564nm @ 0° AOI T(abs): =50% FOR 575±5.75nm @ 0° AOI

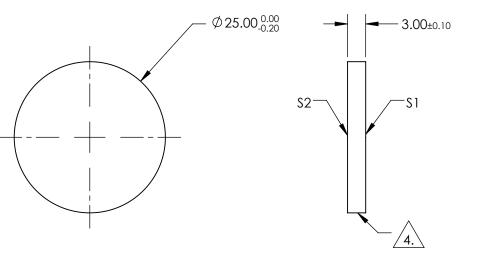
S2:SINGLE LAYER MgF2

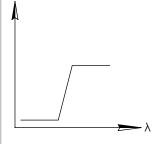
4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









Τ

LONGPASS FILTER			_			Edmund Optics [®]
REV A	S1	S2				
SHAPE	PLANO	PLANO				Ø25mm, 575nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%				
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mi	nm	DWG NO	84745 SHEET 1 OF 1

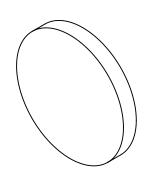
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 635 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 613nm @ 0° AOI T(abs): =50% FOR 625±6.25nm @ 0° AOI

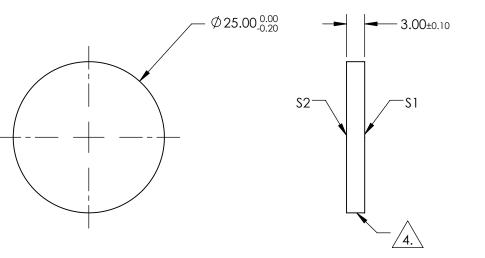
S2:SINGLE LAYER MgF2

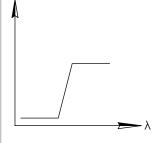
4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









Τ

LONGPASS FILTER			_			Edmund Optic	C ®
REV A	S1	S2					3
SHAPE	PLANO	PLANO		1		Ø25mm, 625nm, HIGH PERFORMANC	^F
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%	'	1			CLIEFT
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84746	Sheet 1 Of 1

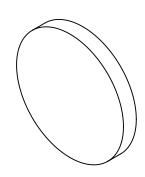
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 685 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 662nm @ 0° AOI T(abs): =50% FOR 675±6.75nm @ 0° AOI

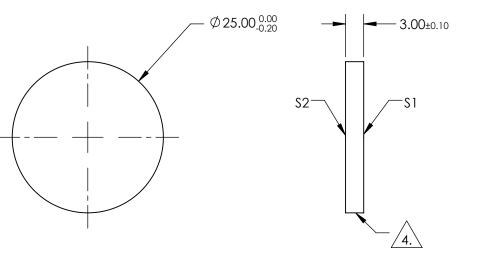
S2:SINGLE LAYER MgF2

4. FINE GRIND SURFACE

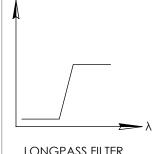
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



Τ

LONGINGSTIELER					Edmund Optics [®]
REV A	S1	\$2			
SHAPE	PLANO	PLANO			Ø25mm, 675nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%			SHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84747 SHEET 1 OF 1